


<b>Search Notes</b>  	<b>Application/Control No.</b>  10656194	<b>Applicant(s)/Patent Under Reexamination</b>  NAKAO, HISAYASU
	<b>Examiner</b>  FARUK HAMZA	<b>Art Unit</b>  2455

### SEARCHED

Class	Subclass	Date	Examiner
709	204-207, 220,223	01/16/11	FH

### SEARCH NOTES

Search Notes	Date	Examiner
Updated East Search (USPAT,USPGPUB,USCOR,EPO,JPO,DERWENT,IBM_TDB)	01/16/11	FH
Inventor Name Search	01/16/11	FH
NPL Search (IEEE,Google)	01/16/11	FH

### INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
709	204-207, 220,223	01/16/11	FH

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